# DISCRETE SEMICONDUCTORS

# DATA SHEET

# **BLF542**UHF power MOS transistor

**Product specification** 

October 1992





# **UHF power MOS transistor**

**BLF542** 

#### **FEATURES**

- · High power gain
- · Easy power control
- · Gold metallization
- · Good thermal stability
- · Withstands full load mismatch
- Designed for broadband operation.

#### **DESCRIPTION**

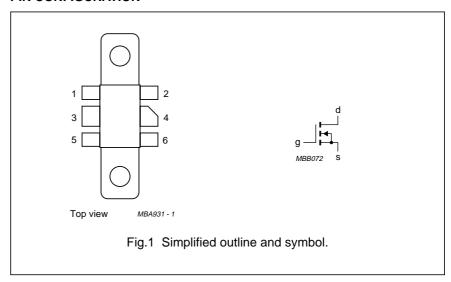
Silicon N-channel enhancement mode vertical D-MOS transistor designed for large signal amplifier applications in the UHF frequency range.

The transistor is encapsulated in a 6-lead, SOT171 flange envelope, with a ceramic cap. All leads are isolated from the flange.

#### **PINNING - SOT171**

PIN	DESCRIPTION						
1	source						
2	source						
3	gate						
4	drain						
5	source						
6	source						

#### **PIN CONFIGURATION**



#### **CAUTION**

The device is supplied in an antistatic package. The gate-source input must be protected against static charge during transport and handling.

#### **WARNING**

#### Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

#### **QUICK REFERENCE DATA**

RF performance at  $T_{mb}$  = 25 °C in a common source test circuit.

MODE OF OPERATION	f	V <sub>DS</sub>	P <sub>L</sub>	G <sub>P</sub>	η <sub>D</sub>	
	(MHz)	(V)	(W)	(dB)	<b>(%)</b>	
CW, class-B	500	28	5	> 13	> 50	

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# **LIMITING VALUES**

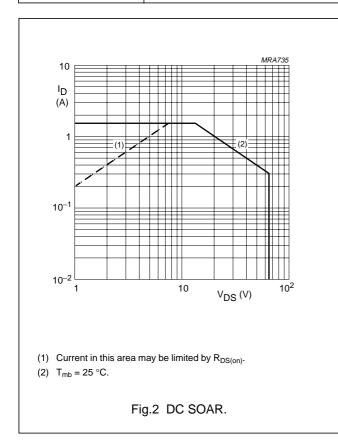
In accordance with the Absolute Maximum System (IEC 134).

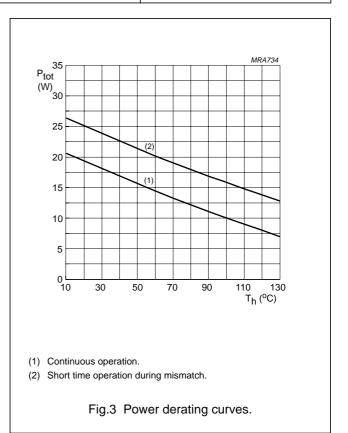
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>DS</sub>	drain-source voltage		_	65	V
±V <sub>GS</sub>	gate-source voltage		_	20	V
I <sub>D</sub>	DC drain current		_	1.5	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C	_	20	W
T <sub>stg</sub>	storage temperature		-65	150	°C
T <sub>i</sub>	junction temperature		_	200	°C

#### THERMAL RESISTANCE

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SYMBOL	PARAMETER	THERMAL RESISTANCE
R <sub>th j-mb</sub>	thermal resistance from junction to mounting base	8.8 K/W
R <sub>th mb-h</sub>	thermal resistance from mounting base to heatsink	0.4 K/W





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# **CHARACTERISTICS**

 $T_j = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$I_D = 0.1 \text{ mA}; V_{GS} = 0$	65	_	_	V
I <sub>DSS</sub>	drain-source leakage current	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V	-	_	10	μΑ
$I_{GSS}$	gate-source leakage current	$\pm V_{GS} = 20 \text{ V}; V_{DS} = 0$	-	_	1	μΑ
V <sub>GS(th)</sub>	gate-source threshold voltage	$I_D = 10 \text{ mA}; V_{DS} = 10 \text{ V}$	2	_	4.5	V
9 <sub>fs</sub>	forward transconductance	I <sub>D</sub> = 0.3 A; V <sub>DS</sub> = 10 V	160	240	_	mS
R <sub>DS(on)</sub>	drain-source on-resistance	$I_D = 0.3 \text{ A}; V_{GS} = 15 \text{ V}$	-	3.3	5	Ω
I <sub>DSX</sub>	on-state drain current	V <sub>GS</sub> = 15 V; V <sub>DS</sub> = 10 V	-	1.4	_	Α
C <sub>is</sub>	input capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	-	14	_	pF
C <sub>os</sub>	output capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	-	9.4	_	pF
C <sub>rs</sub>	feedback capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	-	1.7	_	pF

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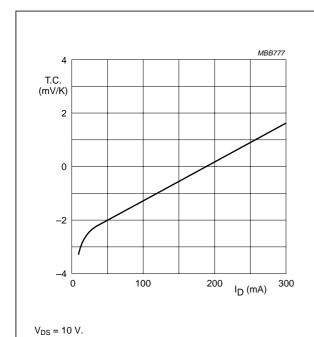


Fig.4 Temperature coefficient of gate-source voltage as a function of drain current, typical values.

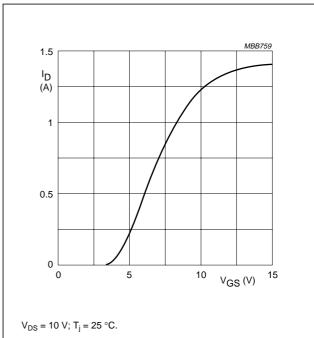


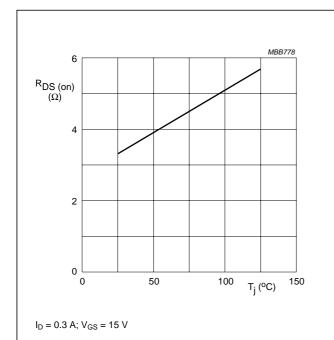
Fig.5 Drain current as a function of gate-source voltage, typical values.

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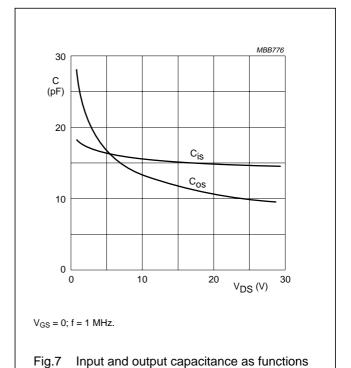
Product specification Philips Semiconductors

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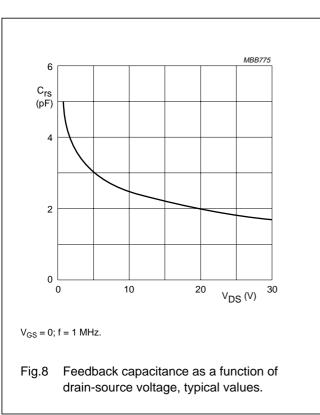
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Drain-source on-resistance as a function of junction temperature, typical values.



of drain-source voltage, typical values.



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# **APPLICATION INFORMATION FOR CLASS-B OPERATION**

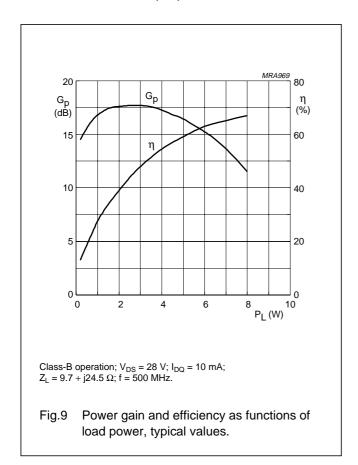
 $T_{mb}$  = 25 °C unless otherwise specified.

RF performance in CW operation in a common source class-B test circuit.

MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	I <sub>DQ</sub> (mA)	P <sub>L</sub> (W)	G <sub>P</sub> (dB)	η <sub>D</sub> (%)
CW, class-B	500	28	50	5	> 13	> 50
					typ. 16.5	typ. 59

# Ruggedness in class-B operation

The BLF542 is capable of withstanding a full load mismatch corresponding to VSWR = 50:1 through all phases under the following conditions:  $V_{DS}$  = 28 V; f = 500 MHz at rated output power.



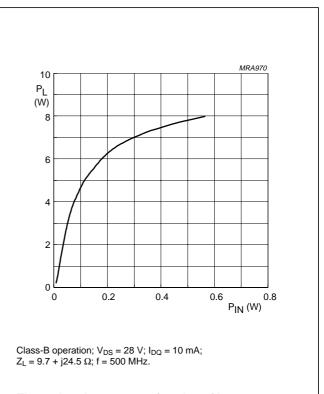
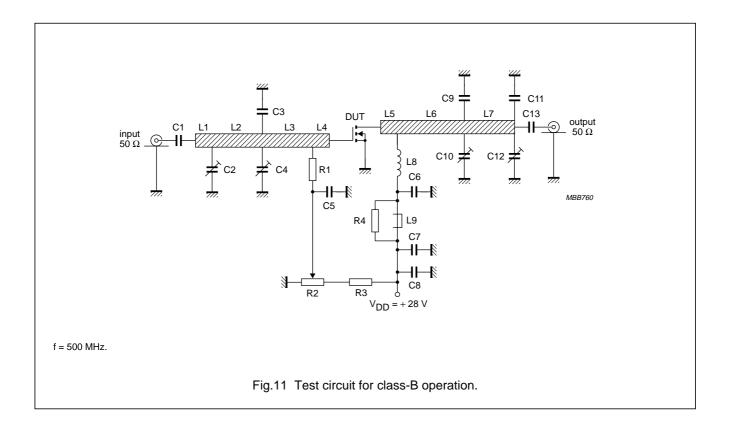


Fig.10 Load power as a function of input power, typical values.

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# List of components (see test circuit)

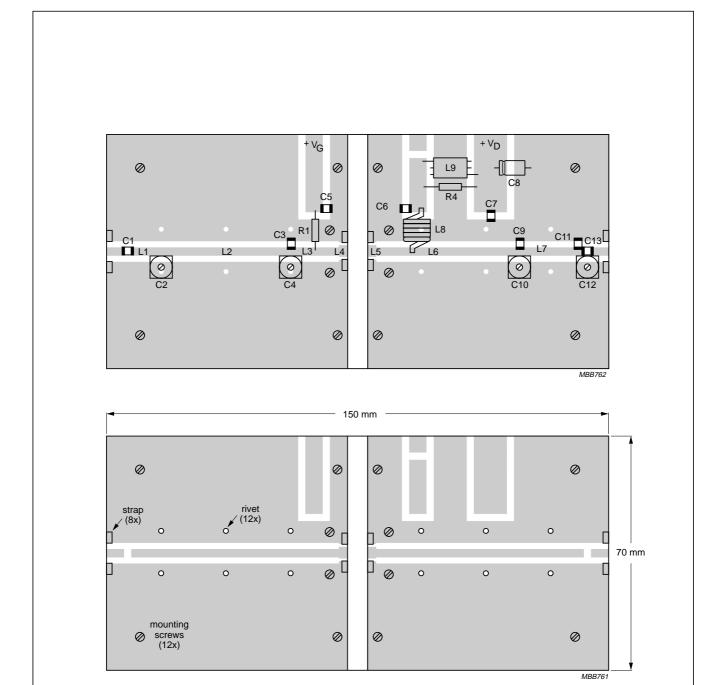
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C5, C13	multilayer ceramic chip capacitor (note 1)	390 pF		
C2, C4, C10, C12	film dielectric trimmer	2 to 18 pF		222 809 05217
C3, C9	multilayer ceramic chip capacitor (note 1)	39 pF		
C6	multilayer ceramic chip capacitor (note 2)	220 pF		
C7	multilayer ceramic chip capacitor	100 nF		2222 852 47104
C8	electrolytic capacitor	63 V, 10 μF		2222 030 28109
C11	multilayer ceramic chip capacitor (note 1)	10 pF		
L1	stripline (note 3)	50 Ω	11 mm × 2.5 mm	
L2	stripline (note 3)	50 Ω	37 mm × 2.5 mm	
L3	stripline (note 3)	50 Ω	13 mm × 2.5 mm	
L4, L5	stripline (note 3)	42 Ω	3 mm × 3 mm	
L6	stripline (note 3)	50 Ω	39 mm × 2.5 mm	
L7	stripline (note 3)	50 Ω	22 mm × 2.5 mm	
L8	8 turns 0.8 mm enamelled copper wire	250 nH	length 9 mm int. dia. 6 mm leads 2 × 5 mm	
L9	grade 3B Ferroxcube wideband RF choke			4312 020 36640
R1	metal film resistor	10 kΩ, 0.4 W		2322 151 71003
R2	10 turn potentiometer	50 kΩ		
R3	metal film resistor	205 kΩ, 0.4 W		2322 151 72054
R4	metal film resistor	10 Ω, 0.4 W		2322 151 71009

# **Notes**

- 1. American Technical Ceramics (ATC) capacitor, type 100A or other capacitor of the same quality.
- 2. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.
- 3. The striplines are on a double copper-clad printed circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness 1/32 inch.

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The components are mounted on one side of a copper-clad printed circuit board; the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by means of fixing screws, hollow rivets and copper foil straps, as shown.

Fig.12 Component layout for 500 MHz test circuit.

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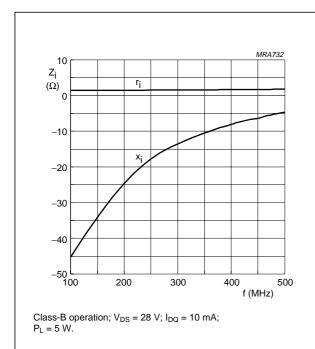
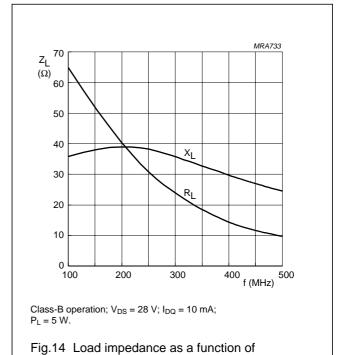
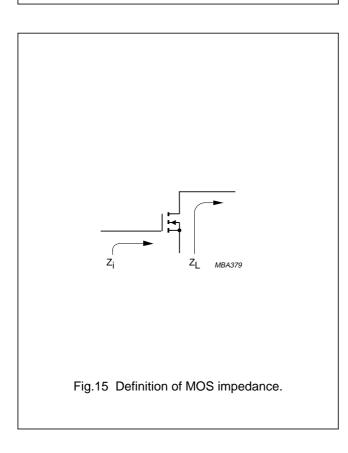


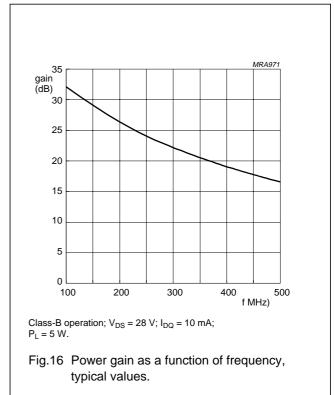
Fig.13 Input impedance as a function of frequency (series components), typical values.



frequency (series components), typical

values.





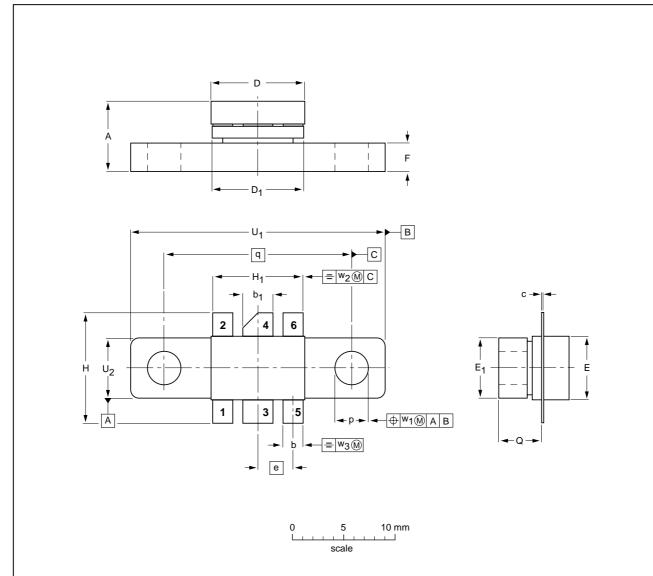
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# **PACKAGE OUTLINE**

Flanged ceramic package; 2 mounting holes; 6 leads

SOT171A



## DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	Α	b	b <sub>1</sub>	C	D	D <sub>1</sub>	Е	E <sub>1</sub>	е	F	н	Н1	р	Q	q	U <sub>1</sub>	U <sub>2</sub>	w <sub>1</sub>	w <sub>2</sub>	w <sub>3</sub>
mm	6.81 6.07	2.15 1.85	3.20 2.89	0.16 0.07	9.25 9.04	9.30 8.99	5.95 5.74	6.00 5.70	3.58	3.05 2.54	11.31 10.54		3.43 3.17	4.32 4.11		24.90 24.63		0.51	1.02	0.26
inches	0.268 0.239	0.085 0.073	0.126 0.114	0.006 0.003	0.364 0.356	0.366 0.354	0.234 0.226	0.236 0.224	0.140	0.120 0.100	0.445 0.415	0.365 0.355	0.135 0.125	0.170 0.162	0.725	0.980 0.970	0.236 0.224	0.02	0.04	0.01

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT171A					97-06-28

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#### **DEFINITIONS**

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

#### **Application information**

Where application information is given, it is advisory and does not form part of the specification.

#### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.